Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/813,993	DOWSKI ET AL.
Examiner	Art Unit
Sheela C. Chawan	2624

SEARCHED					
Class	Subclass	Date	Examiner		
382	128, 232	4/24/2006	scc		
382	255,321	4/24/2006	scc		
359	16,279	4/24/2006	scc		
359	196	4/24/2006	scc		
250	216	4/24/2006	scc		
250	201.9	4/24/2006	scc		
ABOVE	SEARCH	4/24/2006	scc		
UPDAT.					
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
382	128,232	4/24/2006	scc		
382	255,321	4/24/2006	scc		
359	16,196 279	4/24/2006	scc		
250/216,201.9		4/24/2006	scc		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST, USPGPUB,USPAT,EPO,JPO,DERWE NT,IBM-TDB, SEE SEARCH HISTORY PRINTOUT AND UPDATE THE SEARCH.	4/24/2006	scc		
382/128, 232,255,321.CCLS. 359/16,196,279.CCLS. 250/216,201.9.CCLS. US-PATENT ONLY SEE TEXT SEARCH.	4/24/2006	scc		
INVENTOR NAME SEARCH.	4/24/2006	scc		
SEARCH INSPEC DATA BASE.	4/24/2006	SCC		
INTERFERENCE SEARCH , SEE SEARCH HISTORY PRINT OUT.	4/24/2006	scc		